Issue Classification



Application/Control No.

10520310 Examiner

HENOK G HEYI

Applicant(s)/Patent Under Reexamination

VAN DER MARK ET AL.

Art Unit 2627

ORIGINAL							INTERNATIONAL CLASSIFICATION									
CLASS SUBCLASS						CLAIMED							NON-CLAIMED			
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/HENOK G HEYI/ Examiner.Art Unit 2627	01/13/2010	Total Claims Allowed:			
(Assistant Examiner)	(Date)	'	5		
/JOSEPH H FEILD/ Supervisory Patent Examiner.Art Unit 2627	01/13/2010	O.G. Print Claim(s)	O.G. Print Figure		
(Primary Examiner)	(Date)	12	1B		